

# Measurement of

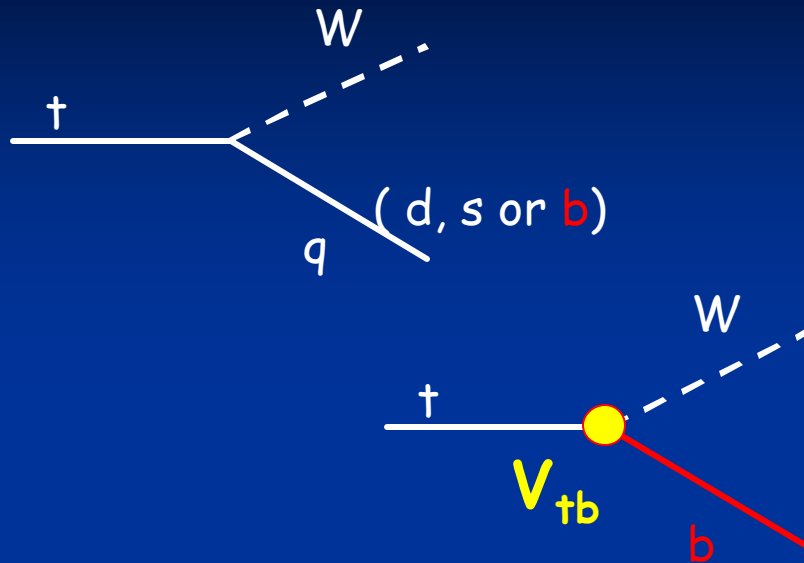
$$R = \frac{B(\tau \rightarrow Wb)}{B(\tau \rightarrow Wq)}$$

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# What is R?



$$R = \frac{|V_{tb}|^2}{|V_{tb}|^2 + |V_{ts}|^2 + |V_{td}|^2}$$

If one assumes three quark generations and CKM unitarity:

$$|V_{tb}| > 0.999 \text{ @ 90\% CL}$$

$$\Rightarrow R > 0.998 \text{ (PDG'04).}$$

We can test SM assumptions using the relative rates of 0-, 1- and 2 tagged b-quarks in top-pair events

If all b-quarks are identified with efficiency  $\epsilon_b$ :

$$N_0 = N_{t\bar{t}} (1 - R \epsilon_b)^2$$

$$N_1 = 2 N_{t\bar{t}} R \epsilon_b (1 - R \epsilon_b)$$

$$N_2 = N_{t\bar{t}} (R \epsilon_b)^2$$

- sensitive to product  $R \epsilon_b$
- overdetermined problem
- $N_{t\bar{t}}$ , and therefore  $\sigma_{\text{top}}$ , cancels in the ratio

# How do we measure R?

Any two tagged rates can be used to measure  $R\epsilon_b$ .

- $\epsilon_b$  is estimated from  $t\bar{t}$  simulation
- Knowing  $\epsilon_b$ , we can extract R!

But....

- we tag b-jets, not b-quarks
- not all b-jets are taggable
- non-b quarks can be tagged too!

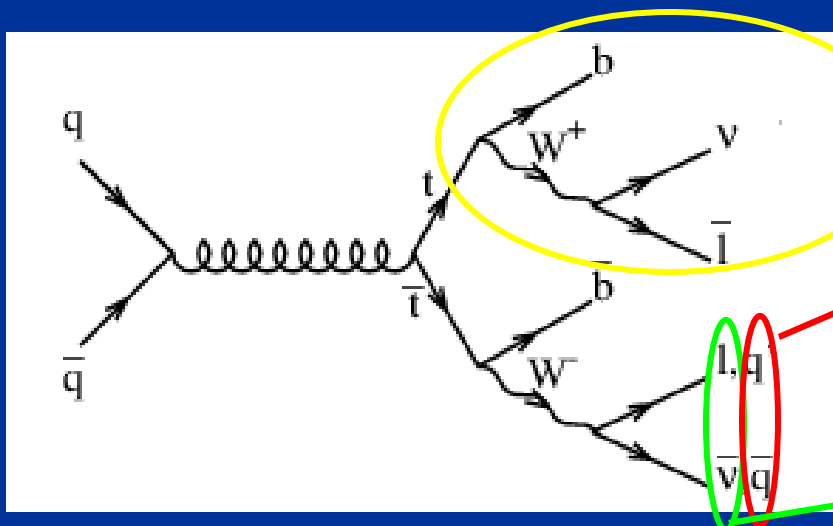
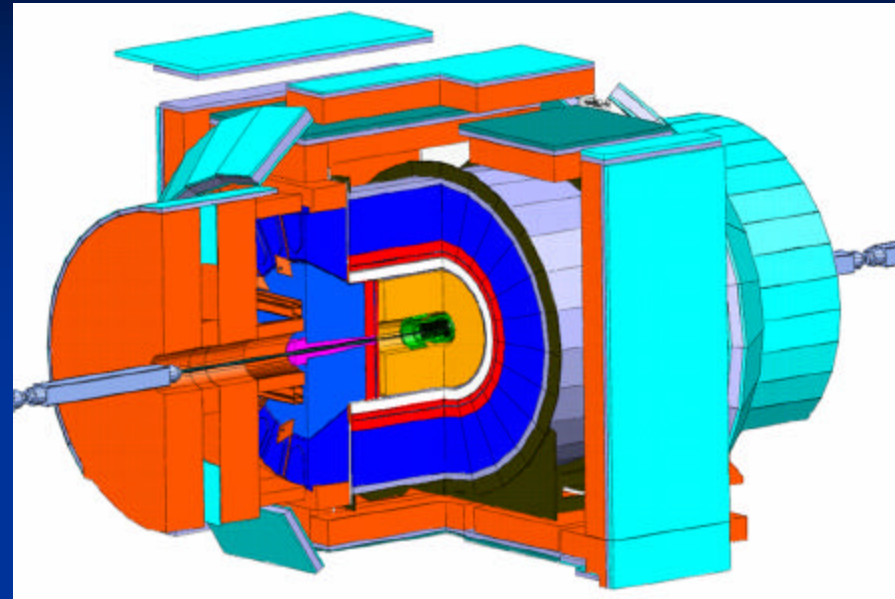
Measure of R proceeds in three steps:

1. Identify samples enriched in  $t\bar{t}$  events
  - Measure number of events in each tagged bin,  $N_{i,obs}$
  - Estimate background in each bin,  $N_{i,bkgr}$
2. Predict tag rates  $\epsilon_i = \epsilon_i (R \epsilon_b)$
3. Compare  $N_{i,exp}$  to  $N_{i,obs}$  using a likelihood technique

# Data Sample

Use 161 pb<sup>-1</sup> of data collected by CDF at  $\sqrt{s} = 1.96$  TeV with good SI detector

Use same samples as for top cross section analysis in **lepton-plus-jets** and **dilepton** channels.



- one 20 GeV isolated lepton ( $e, \mu$ )
- high missing  $E_t$

**L3J:** + exactly 3 jet (high stat.)

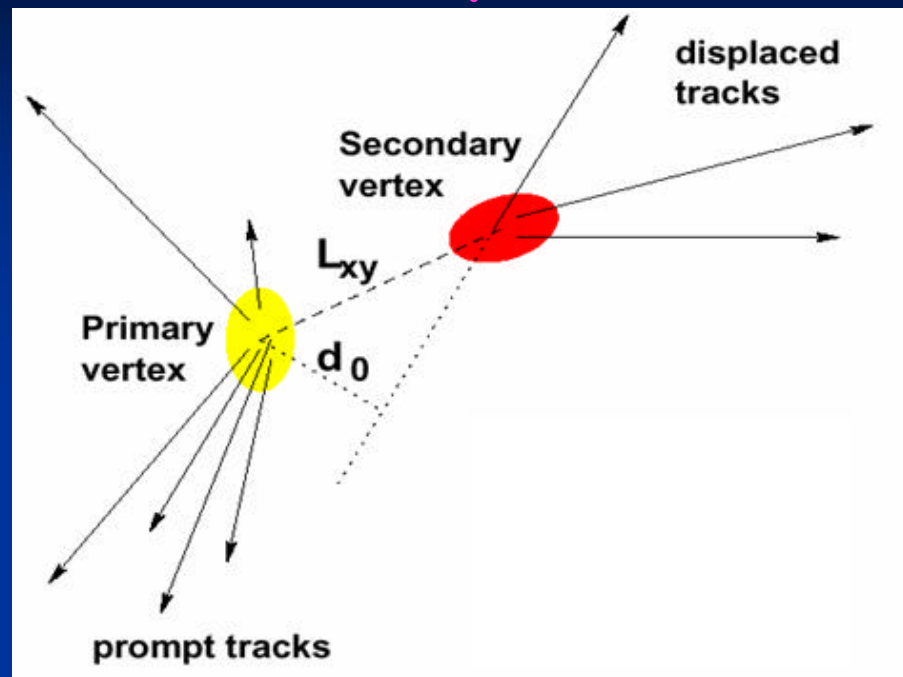
**L4J:** +  $\geq 4$  jets (better S/B)

**LL:** + second lepton  
+ 2 or more jets

# Tagged Samples: $N_{i,obs}$

b-jets are identified using the **SecVtx** algorithm.

- high  $d_0$  tracks in jets are constrained to come from a displaced secondary vertex
- **jet tagging efficiency**: from MC and calibrated with independent data samples: **44%**
- **false tag rate**, from generic QCD jets: **0.5%**



Sample	L3J	L4J	LL
0-tag	358	79	5
1-tag	26	23	4
2-tag	3	5	2

# Tagged Background: $N_{i, \text{bkgr}}$

LL

- Mostly from generic QCD radiation in Z/WW+jets
- Apply false tag probability matrix to pretagged dilepton candidates

LL	0-tag	1-tag	2-tag
$N_{\text{bkgr}}$	$2.0 \pm 0.6$	$0.2 \pm 0.2$	$0.0 \pm 0.0$

L3J(DE)	0-tag	1-tag	2-tag
$N_{\text{bkgr}}$	[0,358]	$16.0 \pm 2.4$	$0.8 \pm 0.2$

L4J(DE)	0-tag	1-tag	2-tag
$N_{\text{bkgr}}$	[0,79]	$4.2 \pm 0.1$	$0.2 \pm 0.1$

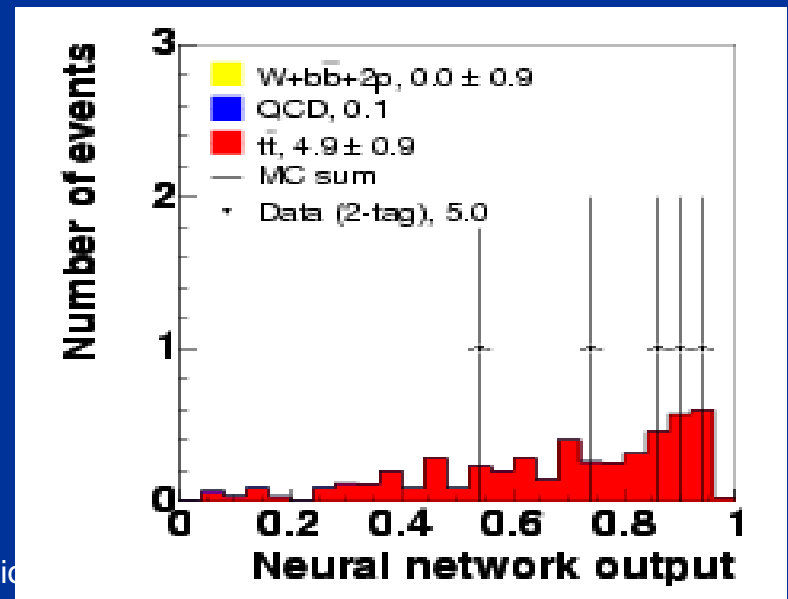
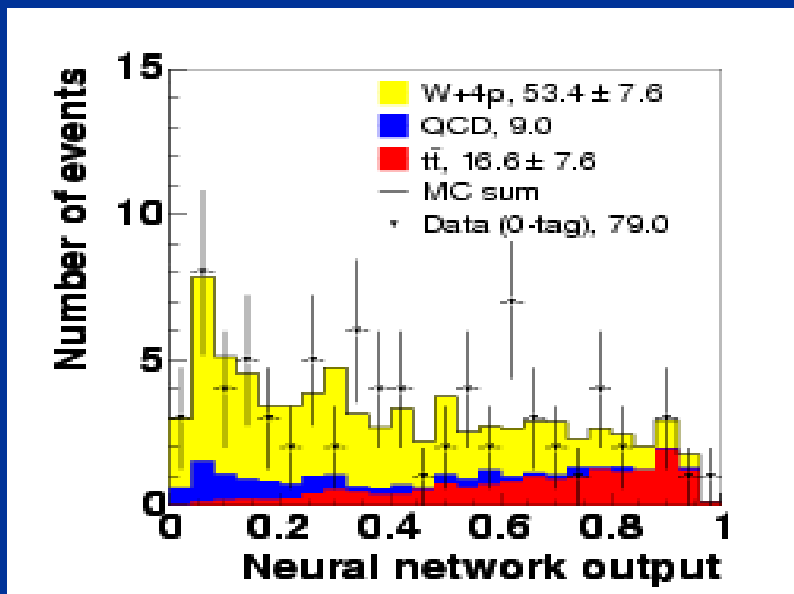
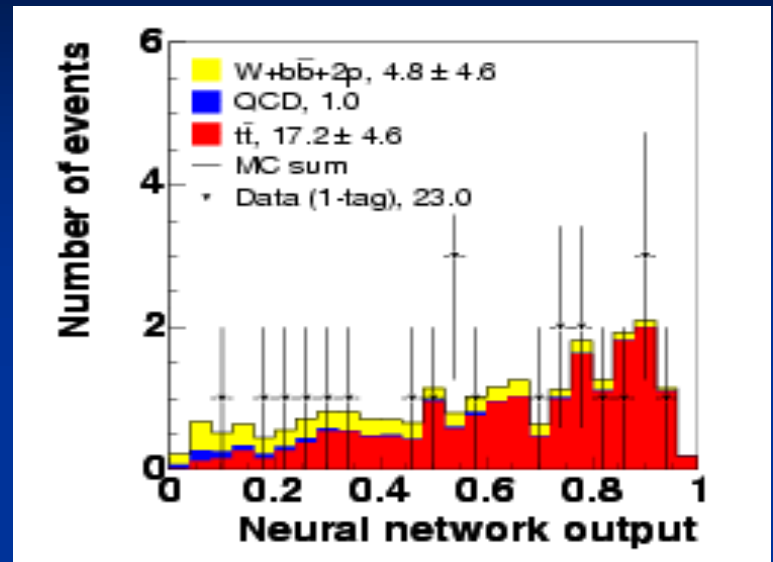
L3J/L4J

- Direct estimate of the SECVTX background rates, using data-driven and simulation based techniques, can be applied only to 1- and 2-tag bins.
- For 0-tag bin, can use at least knowledge of total number of events with no tags.
- Kinematic (NN) analysis provides independent estimate of background rates in each tagged bin which is consistent but less precise than DE.

L4J(NN)	0-tag	1-tag	2-tag
$N_{\text{bkgr}}$	$62.4^{+8.5}_{-9.3}$	$5.8^{+5.6}_{-5.2}$	$0.1^{+0.9}_{-0.0}$

# Lepton+jets Kinematic (NN) Analysis

- Single output NN trained on 9 kinematics variables, independent of b-tagging.
- Used for L4J channel only.
- Fit data to NN output templates for  $t\bar{t}$  and  $W$ +jets background (plus fixed QCD component) to find top signal fractions.



# Event Tagging Efficiencies: $e_i$

Tagged jets can come from a variety of sources.

- We estimate the efficiency to tag different b-like jets using the Monte Carlo

1. b-quark in top decays
2. Light-quarks in top decays ( $\varepsilon_q < 0.01$ )

→ efficiency to tag a jet from top decays is:

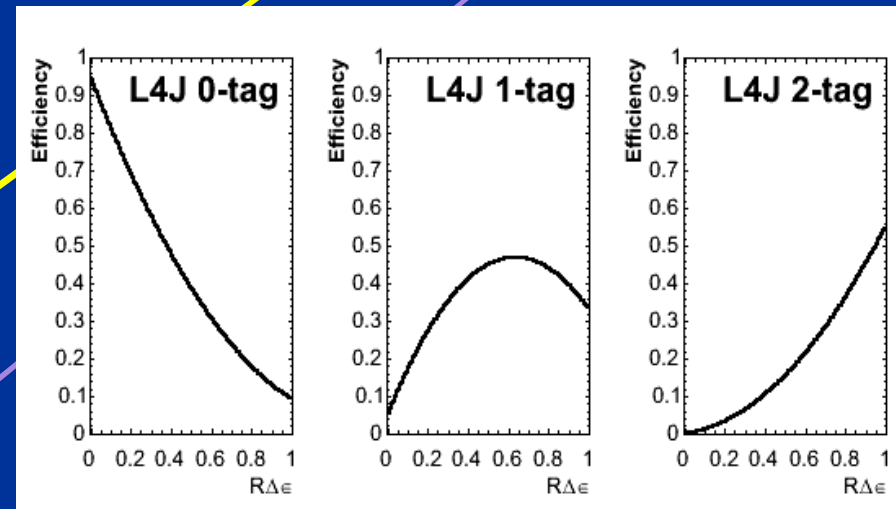
$$R e_b + (1 - R) e_q = R(e_b - e_q) + e_q$$

3. Quarks from W-decay and "other" jets from additional QCD radiation.  
Do not depend on R!

- Tagging efficiency apply only if jets are taggable i.e. within the SecVtx fiducial region.

Event tagging efficiency becomes:

$$e_i = e_i(R \Delta e, e_W, e_o, F_{bW_o})$$





# Likelihood

- We use a **likelihood function** to characterize consistency of the observed tag rates with a given value of  $R\Delta\epsilon$ .

$$\mathcal{L} = \prod_{i \rightarrow \text{tag}} \mathcal{P}(N_{i,\text{obs}}, N_{i,\text{exp}}) \times \mathcal{G}$$

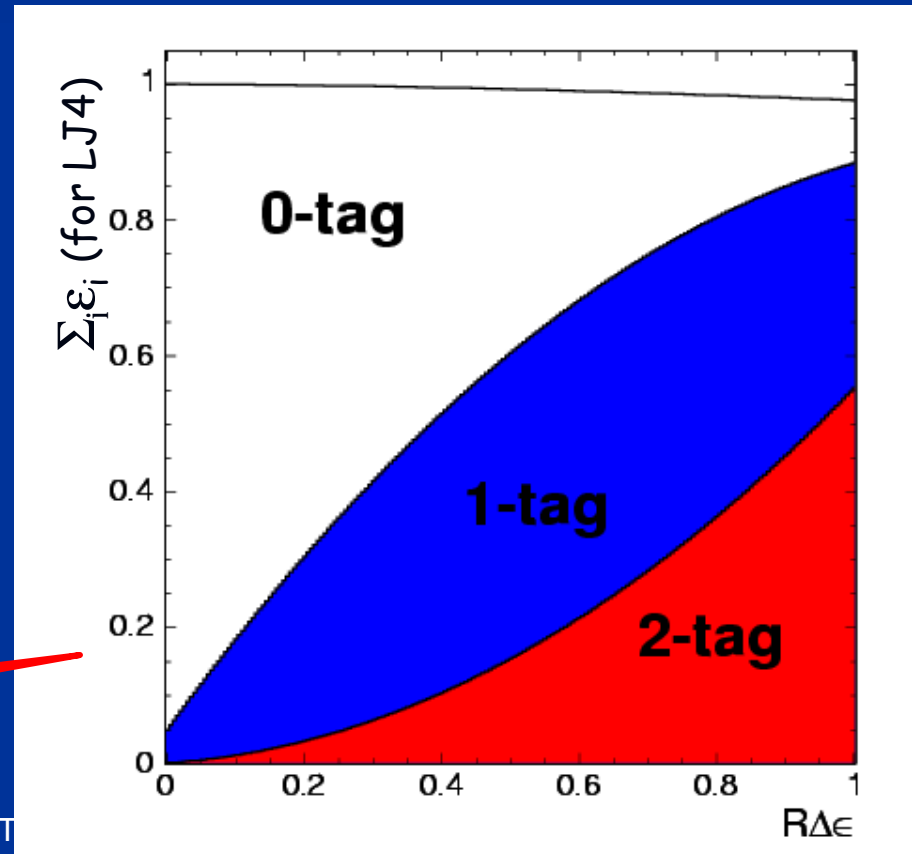
- Inside the Poisson terms  $\mathcal{P}$

$$N_{i,\text{exp}} = N_{\text{pre}} \times e_i + N_{i,\text{bkgr}}$$

- The number of  $t\bar{t}$  candidates before tagging,  $N_{\text{pre}}$ , is dependent on  $R\Delta\epsilon$

$$N_{\text{pre}} = \frac{\sum_j N_{j,\text{obs}} - \sum_i N_{i,\text{bkgr}}}{\sum_i e_i}$$

- The **gaussian term  $\mathcal{G}$**  takes care of **systematic uncertainties** from backgr. normalization and jet efficiencies



# Combined Likelihood

- Final likelihood is the product of likelihoods for the LL, L3J and L4J samples.

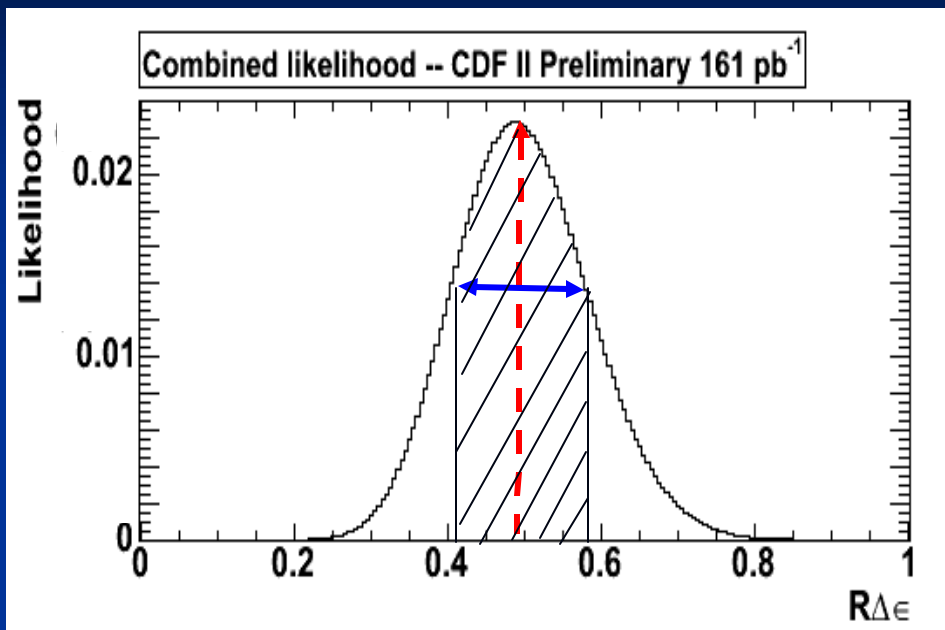
- From peak and interval containing 68% of area:

$$R \Delta e = 0.49^{+0.09}_{-0.08}$$

- Assuming nominal  $\Delta \varepsilon = 0.44 \pm 0.03$ :

$$R = 1.11^{+0.21}_{-0.19}$$

- Statistically limited. Systematics contribute ~15% of total uncertainty, dominated by uncertainty on  $\varepsilon_b$ .



- NN analysis alone produces a prediction for the number of top and background event in each tagged bin and can be used to extract  $R$

$$R = 1.06^{+0.31}_{-0.29}$$

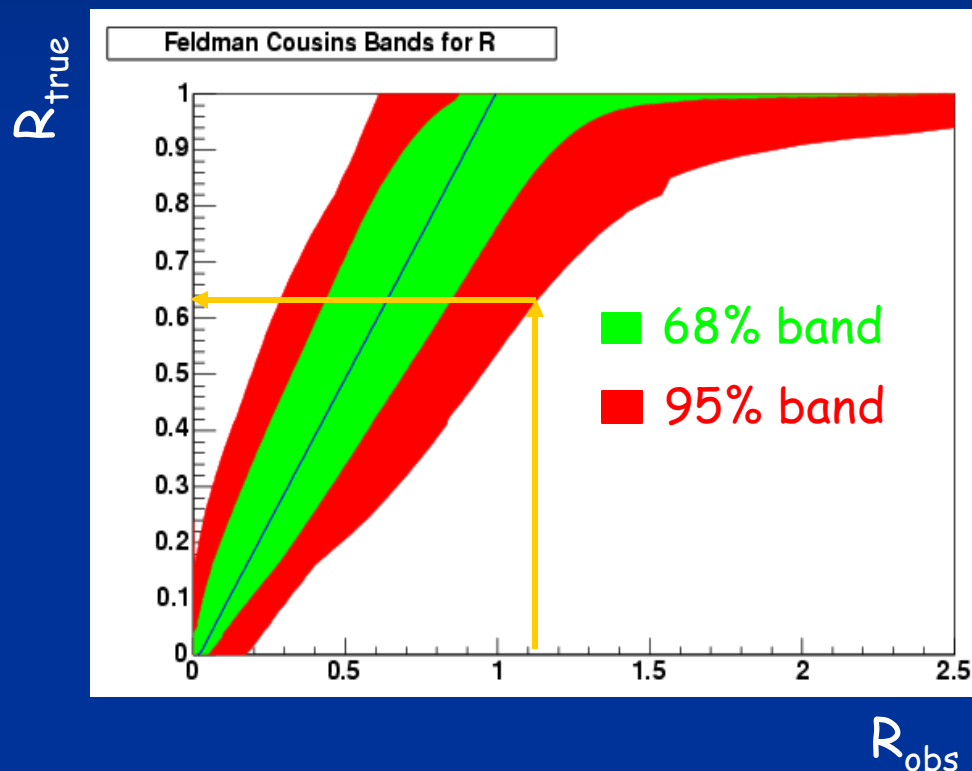
consistent with SecVtx result.

# Feldman-Cousins Limit

- To interpret our combined likelihood result, which is outside physical boundary of  $0 \leq R \leq 1$ , we use FC method to derive 95% acceptance bands for any  $R_{\text{obs}}$  vs  $R_{\text{true}}$
- Acceptance bands include statistical and systematic error

**$R > 0.62$  @ 95 C.L.**

CDF II Preliminary, 161 pb<sup>-1</sup>



# Conclusions

- We have measured the ratio  $R = \frac{B(t \rightarrow Wb)}{B(t \rightarrow Wq)}$  in  $161 \text{ pb}^{-1}$  of top quark decays collected with CDF II
- By comparing the relative rates of identified b-jets in events reconstructed both as dilepton or lepton-plus-jets, we measure:

$$R = 1.11^{+0.21}_{-0.19}$$

or, using Feldman-Cousins limit prescription,

$$R > 0.62 @ 95\% \text{ C.L.}$$

- Improves CDF Run I limit of  $R > 0.56 @ 95 \text{ C.L.}$
- Expect more stringent limit with more statistics!

Measurement of

$$R = \frac{B(\tau \rightarrow Wb)}{B(\tau \rightarrow Wq)}$$

Backup slides

# Partial Sample Results

Sample	$R\Delta\epsilon$ Central value	R (assuming nominal $\Delta\epsilon$ )
SECVTX-only LJ	$0.42^{+0.15}_{-0.14}$	$0.96^{+0.32}_{-0.34}$
SECVTX + NN LJ	$0.45^{+0.10}_{-0.09}$	$1.04^{+0.24}_{-0.21}$
Dilepton	$0.61^{+0.19}_{-0.16}$	$1.40^{+0.45}_{-0.38}$
Combined	$0.49^{+0.09}_{-0.08}$	$1.11^{+0.21}_{-0.19}$

- Uncertainty on R includes 7% from SF uncertainty.

- If we assume  $R=1$ :

$$\Delta e = 0.49^{+0.09}_{-0.08}$$

consistent with nominal value of  $\Delta e = 0.44 \pm 0.03$

- $\Delta\epsilon$  in dilepton and lepton plus jets agree.

# Feldman-Cousin Method

FC prescribes a method that unifies 1-sided vs 2-sided interval and ensures a physical results.

1. Find expected  $R_{\text{obs}}$  for different values of  $R_{\text{true}}$
2. For each  $R_{\text{true}}$  set  $\alpha\%$  confidence bands in  $R_{\text{meas}}$  using a likelihood ratio ordering principle
3. Find smallest  $R_{\text{true}}$  for which  $R_{\text{obs}}$  is inside confidence band

